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To Call Writer Directly: 212-445-4927 Jhenes@kirkland.com

KIRKLAND & ELLIS LLP

MEMO ENDORSED

Chagroup Center 153 East 53rd Street New York, New York 10022-4611

212 448 4800

www.kirkland.com

Facsimile: 212 446-4900

February 28, 2008

By Facsimile With Permission (212) 805-7910

Honorable Lewis A. Kaplan United States District Court for the Southern District of New York United States Courthouse 500 Pearl St., Room 1310 New York, NY 10007

Re:

In re Solutia Inc., Civil Action Nos. 1:08-cv-10046-LAK, 1:08-cv-

00063-LAK, 1:08-cv-00064-LAK Chapter 11 Case No. 03-17949-PCB

Dear Judge Kaplan:

As you know, Kirkland & Ellis LLP represents Solutia Inc. ("Solutia") in the abovereferenced appeals and chapter 11 case. Solutia, together with the other parties in the abovereferenced appeals, Appellant The Bank of New York, as indenture trustee for the 11.25% Senior Secured Notes (the "Indenture Trustee") and Appellee and Cross-Appellant the Official Committee of Unsecured Creditors of Solutia Inc., et al., consistent with Judge Kaplan's regular memo endorsement, hereby request that the above-referenced appeals be dismissed with prejudice. The settlement between Solutia, the Indenture Trustee and certain holders of the 11.25% Senior Secured Notes approved by the Honorable Prudence Carter Beatty, United States Bankruptcy Judge, on February 26, 2008, has been consummated.

We appreciate the Court's courtesy with respect to this requests.

Sincerely.

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KIRKLAND & ELLIS LLP

Honorable Lewis A. Kaplan February 28, 2008 Page 2

CC. Martin J. Bienenstock, Esq. Judy G. Z. Liu, Esq. Dewey & LeBoeuf LLP Attorneys for Appellant The Bank of New York, as Indenture Trustee for the 11.25% Senior Secured Notes

> Daniel H. Golden, Esq. Akin Gump Strauss Hauer & Feld LLP Attorneys for Appellee and Cross-Appellant The Official Committee of Unsecured Creditors of Solutia Inc., et al.